

# EXPECTED SIGNATURE STUFF

CIRM "Pathwise Stochastic Analysis & Applications"  
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joint works with

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Datasig, AT1, OMI

For a  $\mathbb{R}^d$ -valued random variable  $X$   
the sequence of moments

$$\left( \mathbb{E}[X^{\otimes m}] \right)_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

is useful.

For a stochastic process  $X = (X_t)_{t \geq 0}$

the sequence of signature moments

$$\left( \mathbb{E}[\int dX^{\otimes m}] \right)_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

is useful.

I. INDEPENDENT COMPONENT ANALYSIS

II. ADAPTED TOPOLOGIES

IcaA

$A$  an invertible  $(d \times d)$ -matrix  
 $X, Y \in \mathbb{R}^d$ -valued random variables

$$Y = A \cdot X$$

Diagram illustrating the relationship between variables and matrices:

- $Y$  is labeled "observations" (indicated by a red arrow pointing to  $Y$ ).
- $A$  is labeled "Mixing matrix" (indicated by a red arrow pointing to  $A$ ).
- $X$  is labeled "sources" (indicated by a red arrow pointing to  $X$ ).

## GOAL

$X$  has independent coordinates

Given (empirical) law of  $Y$ , recover  $X$  (resp.  $A$ )

→ 80's

Hérault & Jutten, Comon, Cardoso, ...

# POSSIBLE?

For  $D$  diagonal matrix  
 $P$  permutation matrix

$$Y = A \cdot X = \underbrace{A P^{-1} D^{-1}}_{\tilde{A}} \cdot \underbrace{D P X}_{\tilde{X}}$$

# NEW GOAL

$\text{Mon}(\mathbb{R}^d) := \{ M : (d \times d)\text{-matrix, } M = DP \text{ for } D \text{ diagonal } \}$   
 $P$  Permutation

Given the (empirical) distribution of  $Y$  find a

$\tilde{X}$  such that  $\tilde{X} \equiv_{\text{Mon}} X$

### Theorem (Comon '94)

$X = (X^1, \dots, X^d)^T$  with  $X^i \perp X^j$ , at most one  $X^i$  Gaussian

$A$  an orthogonal (wlog)  $d \times d$  matrix

$$Y = A \cdot X$$

Then

$BY \stackrel{\text{Mon}}{\equiv} X$  IFF  $BY$  has independent coordinates

Corollary Given

$$\Phi: \{ \text{probability measures on } \mathbb{R}^d \} \longrightarrow [0, \infty)$$

such that

$$\Phi(\mu) = 0 \quad \text{IFF} \quad \mu = \mu^1 \otimes \dots \otimes \mu^d$$

Then  $\hat{B} := \underset{B}{\operatorname{argmin}} \Phi(\operatorname{Law}(BY))$  fulfills  $\hat{B}Y \stackrel{\text{Mon}}{\equiv} X$

Theorem Let  $Y$  be a  $\mathbb{R}^d$ -valued random variable such that the sequence of moments

$$(\mu_Y^m)_{m \geq 0} := (\mathbb{E}[Y^{\otimes m}])_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

characterizes the law of  $Y$ . The sequence of cumulants

$$(\kappa_Y^m)_{m \geq 0} := \pi_{\Sigma_T m}(\log \mathbb{E}[\exp(Y)]) \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

fulfills

$$\text{i)} \quad \langle \kappa_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a (-1)^{|a|-1} (|a|-1)! \prod_i \langle \mu_Y, e_{a_i} \rangle$$

with  $\sum_a$  over all partitions  $a = (a_1, \dots, a_k)$  of  $(i_1, \dots, i_m)$

$$\text{ii)} \quad \kappa_Y \mapsto \mu_Y \quad \text{bijective} \quad \langle \mu_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a \prod_i \langle \kappa_Y, e_{a_i} \rangle$$

$$\text{iii)} \quad I, J \subset \{1, \dots, d\}. \quad \text{Then } (Y^i)_{i \in I} \perp\!\!\!\perp (Y^j)_{j \in J}$$

$$\text{IFF} \quad \langle \kappa_Y, e_{\tau_1} \otimes e_{\tau_2} \rangle = 0 \quad \forall \tau_1 \in I^*, \tau_2 \in J^*$$

$\rightarrow$  T. SP@ED publicized the combinatorial point of view in statistics



Take for  $\Phi(\text{Law}(Y)) = \sum_m \sum_{i_1, \dots, i_m} \langle k_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle^2$

In practice :  $\frac{1}{N} \sum_{j=1}^N \delta_{Y_j} \approx \text{Law}(Y)$

POLYKAYS

→ SOLVE ICA by optimization

→ Many extensions, for example

$$Y_t = A \cdot X_t \quad t = 0, 1, 2, \dots$$

(Blind Source Separation, cocktail party problem, ...)

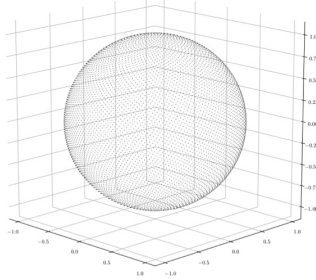
# NONLINEAR ICA IN CONTINUOUS TIME

$$Y_t = f(X_t)$$

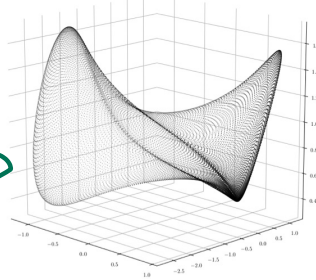
with  $f: \mathbb{R}^d \rightarrow \mathbb{R}^d$   $C^3$ -diffeomorphism  
 $(X_t)_{t \geq 0}$   $d$ -dimensional stochastic process with  
independent coordinates

Philosophy: Exploit temporal structure to solve harder problem

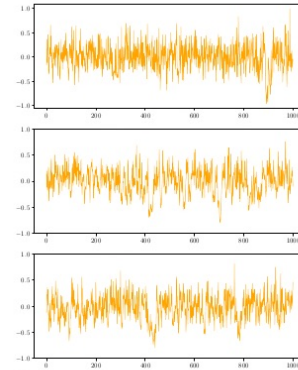
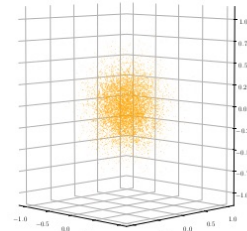
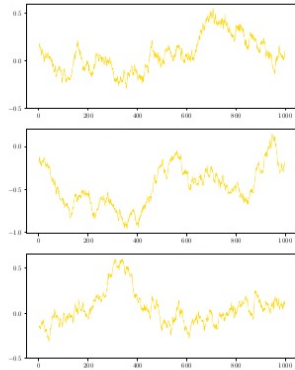
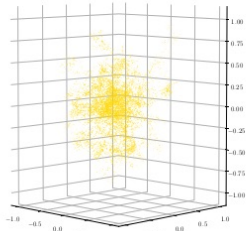
→ Contrastive learning: Hyvärinen & Morioka 2016



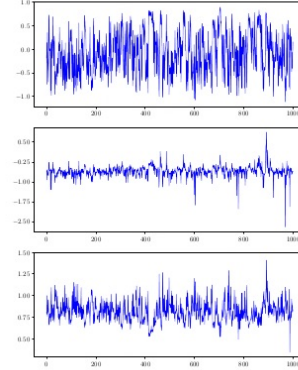
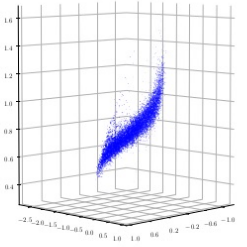
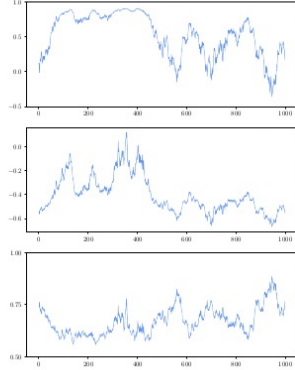
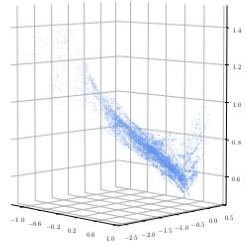
$f$  →



$(X_t)_{t \geq 0}$



$(Y_t)_{t \geq 0}$



## Theorem (Schell & O)

Let  $(X_t)_{t \geq 0}$  be a  $d$ -dimensional

$\alpha$ - or  $\beta$ - or  $\gamma$ -contrastive

stochastic process with independent coordinates.

Let  $h: \mathbb{R}^d \rightarrow \mathbb{R}^d$  be a  $C^3$ -diffeomorphism.

Then

$h \circ Y \stackrel{\text{Mon}}{\equiv} X$  IFF  $h \circ Y$  has ind.-coord.

Corollary Let

$$\Phi: \{ \text{Laws of stochastic processes} \} \rightarrow [0, \infty)$$

such that

$$\Phi(\mu) = 0 \quad \text{IFF} \quad \mu = \mu^1 \otimes \dots \otimes \mu^d$$

Then

$$\hat{h} := \operatorname{argmin}_h \Phi(\text{Law}(h \circ Y))$$

solves  $\hat{h} \circ Y \stackrel{\text{Mon}}{=} X$

Theorem Let  $Y$  be a  $\mathbb{R}^d$ -valued random variable such that the sequence of moments

$$(\mu_Y^m)_{m \geq 0} := (\mathbb{E}[Y^{\otimes m}])_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

characterizes the law of  $Y$ . The sequence of cumulants

$$(\kappa_Y^m)_{m \geq 0} := \pi_{\Sigma Y^m}(\log \mathbb{E}[\exp(Y)]) \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

fulfills

$$\text{i)} \quad \langle \kappa_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a (-1)^{|a|-1} (|a|-1)! \prod_i \langle \mu_Y, e_{a_i} \rangle$$

with  $\sum_a$  over all partitions  $a = (a_1, \dots, a_k)$  of  $(i_1, \dots, i_m)$

$$\text{ii)} \quad \kappa_Y \mapsto \mu_Y \quad \text{bijective} \quad \langle \mu_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a \prod_i \langle \kappa_Y, e_{a_i} \rangle$$

$$\text{iii)} \quad I, J \subset \{1, \dots, d\}. \quad \text{Then } (Y^i)_{i \in I} \perp\!\!\!\perp (Y^j)_{j \in J}$$

$$\text{IFF} \quad \langle \kappa_Y, e_{\tau_1} \otimes e_{\tau_2} \rangle = 0 \quad \forall \tau_1 \in I^*, \tau_2 \in J^*$$

## Theorem (Bonnier & O)

Let  $Y$  be a bounded variation process such that the sequence of signature moments

$$(\mu_Y^m)_{m \geq 0} := (\mathbb{E}[\int dY^{\otimes m}])_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

characterizes the law of  $Y$ . The sequence of signature cumulants

$$(\kappa_Y^m)_{m \geq 0} := \log(\mathbb{E}[\int dY^{\otimes m}])_{m \geq 0} \in \prod_{m \geq 0} (\mathbb{R}^d)^{\otimes m}$$

fulfills

$$\text{i)} \quad \langle \kappa_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a (-1)^{|a|-1} \frac{a!}{|a|} \mu_X(a)$$

with  $\sum_a$  over all **ordered partitions** of  $(i_1, \dots, i_m)$

$$\text{ii)} \quad \kappa_Y \mapsto \mu_Y \text{ bijective} \quad \langle \mu_Y, e_{i_1} \otimes \dots \otimes e_{i_m} \rangle = \sum_a \frac{1}{|a|!} \kappa_X(a)$$

$$\text{iii)} \quad I, J \subset \{1, \dots, d\}. \text{ Then } (Y^i)_{i \in I} \perp\!\!\!\perp (Y^j)_{j \in J}$$

$$\text{IFF} \quad \langle \kappa_Y, e_{\tau_1} \otimes e_{\tau_2} \rangle = 0 \quad \forall \tau_1 \in I^*, \tau_2 \in J^*$$

# IN PRACTICE

$$\operatorname{argmin}_h \mathbb{E} (\text{Law}(h \circ Y))$$

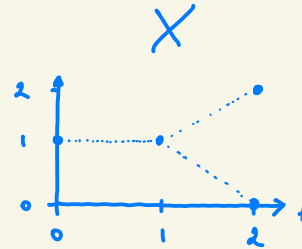
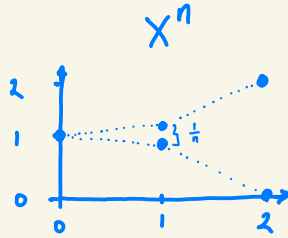
- $\text{Law}(h \circ Y)$  estimated by empirical measure ergodicity
- $\mathbb{E}$  signature polykeys
- $\operatorname{argmin}$  over NN  $h$  + SGD



# III ADAPTED TOPOLOGIES

# WEAK TOPOLOGY ... IS WEAK

## Example 1



$X^n \rightarrow X$  weakly as  $n \rightarrow \infty$

## Example 2

$(\Omega, \mathcal{G}, P, X) \mapsto \sup_{\tau} E[L_{\tau}]$  is not continuous

- ALDOUS, RÜSCHENDORF, VERSHIK, HOOVER & KEISLER & MANY OTHERS
- BACHHOFF, BARTL, BEIGLBOCK, EDER

$$I = \{0, \dots, T\}$$

"time"

$U$

"state space", compact subset of linear space  $V$

$$\underline{X} = (\Omega, \mathcal{G}, \mathbb{P}, X)$$

adapted stochastic process on a filtered probability space  $(\Omega, \mathcal{G}, \mathbb{P})$  with coordinate process  $X = (X_t)_{t \in I}$

$\mathcal{S}(U)$

the set of adapted processes with state space  $U$

## WHAT TOPOLOGY ON $\mathcal{S}(U)$ ?

Recall: Weak convergence says

$$\underline{X}^n \xrightarrow[n \rightarrow \infty]{} \underline{X} \quad \text{IFF} \quad \mathbb{E}[f(X_{t_1}^n, \dots, X_{t_m}^n)] \rightarrow \mathbb{E}[f(X_{t_1}, \dots, X_{t_m})]$$

$\forall f \in C_b(U^m, \mathbb{R}) \quad t_1, \dots, t_m \in I$

The set of adapted functionals  $AF$  consists of maps that map an element of  $\mathcal{S}(U)$  to a real-valued random variable. It is defined inductively:

i for  $t_1, \dots, t_n \in I$  and  $f \in C_b(U^n, \mathbb{R})$

$$\underline{X} \mapsto f(X_{t_1}, \dots, X_{t_n}) \in AF$$

ii for  $f_1, \dots, f_n \in AF$  and  $f \in C_b(\mathbb{R}^n, \mathbb{R})$

$$\underline{X} \mapsto f(f_1(\underline{X}), \dots, f_n(\underline{X})) \in AF$$

iii for  $t \in I$  and  $f \in AF$

$$\underline{X} \mapsto \mathbb{E}[f(\underline{X}) | \mathcal{G}_t] \in AF$$

Denote with  $AF_r \subset AF$  the subset that can be built with at most  $r$  conditional expectations (Point iii).

The adapted topology of rank  $r$  on  $\mathcal{S}(U)$  is defined by

$$\lim \underline{X}_n = \underline{X} \quad \text{IFF} \quad \lim \mathbb{E}[f(\underline{X}_n)] = \mathbb{E}[f(\underline{X})] \quad \forall f \in AF_r$$

Another natural quantity to associate with an adapted process  $\underline{X}$  is the so-called prediction process  $\hat{X}^r$  of rank  $r$  defined inductively as

$$\hat{X}_t^0 := X_t$$

$$\hat{X}_t^{r+1} := \mathbb{P}(\hat{X}^r \in \cdot \mid \mathcal{F}_t)$$

Note:

$\hat{X}_t^0$	takes values in	$U$
$\hat{X}_t^1$	-  -	$\mathcal{M}(I \rightarrow U)$
$\hat{X}_t^2$	-  -	$\mathcal{M}(I \rightarrow \mathcal{M}(I \rightarrow U))$
$\vdots$	$\vdots$	
$\hat{X}_t^{r+1}$	-  -	$\mathcal{M}(I \rightarrow \mathcal{M}(\dots \mathcal{M}(I \rightarrow U) \dots))$

$$\lim_n \underline{X}_n = \underline{X} \quad \text{IFF} \quad \hat{X}_n^r \xrightarrow[n \rightarrow \infty]{\text{weakly}} \hat{X}^r$$

Both, AF & Prediction Process, give a topology for  $\mathcal{S}(U)$ .

**WHICH SHOULD WE USE?**

Theorem Let  $\underline{X}, \underline{Y} \in \mathcal{S}(U)$ . TFAE for every  $r \geq 0$

i)  $\mathbb{E}[f(\underline{X})] = \mathbb{E}[f(\underline{Y})] \quad \forall f \in AF_r$

ii)  $\text{Law}(\hat{X}^r) = \text{Law}(\hat{Y}^r)$

We call the resulting topology on  $\mathcal{S}(U)$  the adapted topology of rank  $r$

HOW DO WE DESCRIBE THE LAW OF A PROCESS (such as  $\hat{X}^r$ )?

→ SIGNATURE MOMENTS

**CAVEAT**

STATE SPACE OF  $\hat{X}^r$  IS PRETTY BIG!

LET'S START AT  $r=0$  AND WORK OUR WAY UP

# PATHS IN PATHS IN ...

$U$

$$U_0 := U$$

$$U_1 := (I \rightarrow U_0)$$

$$U_2 := (I \rightarrow U_1) \equiv I \rightarrow (I \rightarrow U)$$

$\vdots$

$$U_r := (I \rightarrow U_{r-1}) \equiv I \rightarrow (I \rightarrow (\dots (I \rightarrow \underbrace{(I \rightarrow U)}_{U_1}) \dots))$$

$U_r$

Paths of rank  $r$

# RANDOM PATHS IN RANDOM PATHS IN ...

$$\mathcal{M}_0 := U$$

$$\mathcal{M}_1 := \mathcal{M}(I \rightarrow \mathcal{M}_0) \equiv \mathcal{M}(I \rightarrow U)$$

$$\mathcal{M}_2 := \mathcal{M}(I \rightarrow \mathcal{M}_1) \equiv \mathcal{M}(I \rightarrow \mathcal{M}(I \rightarrow U))$$

$\vdots$

$$\mathcal{M}_r := \mathcal{M}(I \rightarrow \mathcal{M}_{r-1}) \equiv \dots$$

Measures of rank  $r$

For a linear space  $V$  denote  $T(V) := \prod_{m \geq 0} V^{\otimes m}$

$T(V)$  is a linear space, and we can repeat this construction

$$T_0(V) := V \quad T_{r+1}(V) := T(T_r(V))$$

(I'm cheating here)  
 → Korusch & Pakas

EXAMPLE

$$\begin{aligned}
 x \in (I \rightarrow (I \rightarrow (I \rightarrow U))) &\equiv U_3 \\
 &\downarrow S \\
 (I \rightarrow (I \rightarrow T(V))) & \\
 &\downarrow S \\
 (I \rightarrow T(T(V))) & \\
 &\downarrow S \\
 T(T(T(V))) &
 \end{aligned}$$



# HIGHER RANK SIGNATURES

Define the family of maps  $S_r : U_r \rightarrow T_r(V)$  inductively by setting

$$S_1 := S$$

$$S_{r+1}(x) := S(x^* S_r)$$

where  $x^* S_r$  is the pullback of  $S_r$  along  $x^*$ .

PROPOSITION The maps  $S_r : U_r \rightarrow T_r(V)$  are injections.

# HIGHER RANK EXPECTED SIGNATURES

Define the family of maps  $\bar{S}_r: \mathcal{M}_r \rightarrow T_r(V)$  inductively by setting

$$\bar{S}_1(\mu) := \int S(x) \mu(dx)$$

$$\bar{S}_{r+1}(\mu) := \int S(x^* \bar{S}_r) \mu(dx)$$

## PROPOSITION

For every  $r \geq 1$  the maps

$$S_r: U_r \longrightarrow T_r(V)$$

$$\bar{S}_r: \mathcal{M}_r \longrightarrow T_r(V)$$

are injective.

For  $r=1$ ,  $S_1$  is the usual signature

$\bar{S}_1$  is the usual expected signature

THEOREM For every  $r \geq 0$  the map

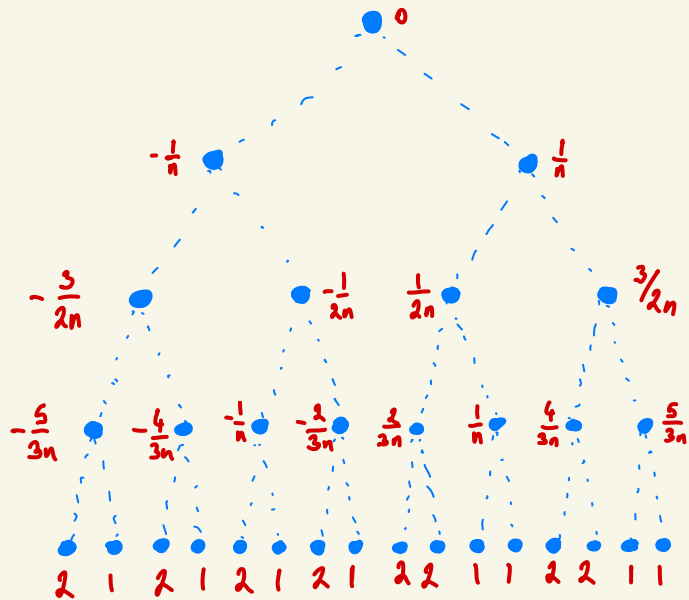
$$d_r : \mathcal{S}(U) \times \mathcal{S}(U) \longrightarrow [0, \infty)$$
$$(\underline{X}, \underline{Y}) \longmapsto \left\| \underbrace{\bar{S}_{r+1}(\text{Law}(\hat{X}^r))}_{\Phi(\underline{X})} - \underbrace{\bar{S}_{r+1}(\text{Law}(\hat{Y}^r))}_{\Phi(\underline{Y})} \right\|_{T_{r+1}(U)}$$

is a metric that metrizes the adapted topology of rank  $r$ .

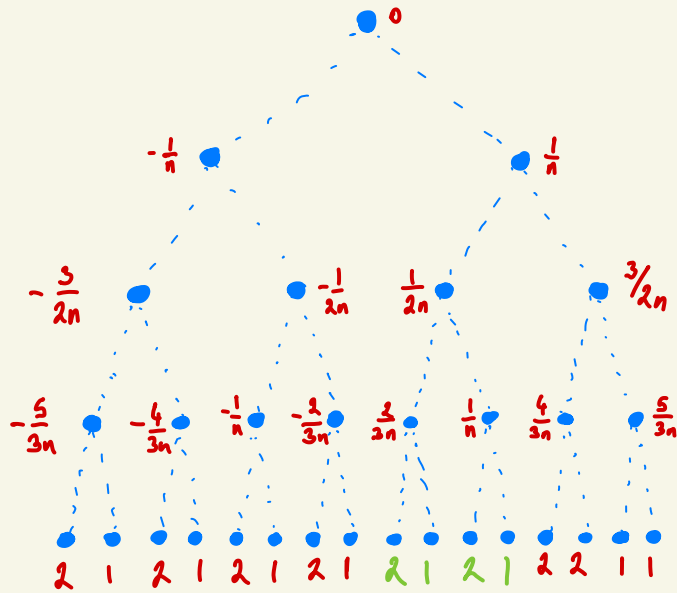
$\Phi(\underline{X})$  yields much more than a metric. It gives us a (multi-)graded description of the law of  $\underline{X}$  and how it interacts with the filtration.

# Example (Hoover-Keister 84): FILTRATIONS $\cong$ TREES

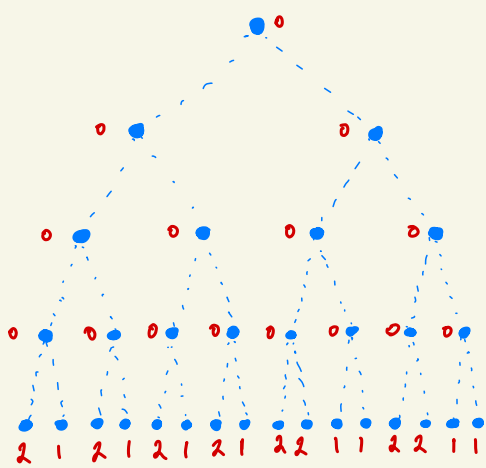
& WHY WE NEED HIGHER RANK TOPOLOGIES



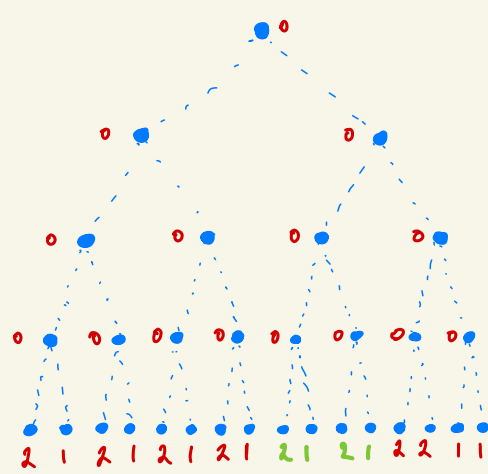
$X^n$



$Y^n$



$$\underline{X}^n \rightarrow \underline{X}$$



$$\underline{Y}^n \rightarrow \underline{Y}$$

X = Y in  $r=0,1$  adapted topology

BUT

$$\mathbb{E}[\mathbb{E}[X_4 | \mathcal{F}_3]^2 | \mathcal{F}_1] = \begin{cases} 5/2 \\ 9/4 \end{cases} \text{ with probability } \frac{1}{2}$$

$$\mathbb{E}[\mathbb{E}[Y_4 | \mathcal{F}_3]^2 | \mathcal{F}_1] = \frac{19}{8}$$

HENCE X, Y are not close in rank  $r=2$  topology

# EXECUTIVE SUMMARY

- i structured description of STOCHASTIC PROCESS AND ITS FILTRATION in terms of (multi)-graded tensors
- ii natural feature map for sequential decision making induces the adapted topology of rank  $r$  for any  $r \geq 0$
- iii interesting new structures in finite discrete time discontinuity not due to roughness

THANKS FOR YOUR TIME!

→ SCHEU, O "Nonlinear ICA in continuous time"

→ BONNIER, LIU, O "Higher Rank Signatures and Adopted Topologies"

